
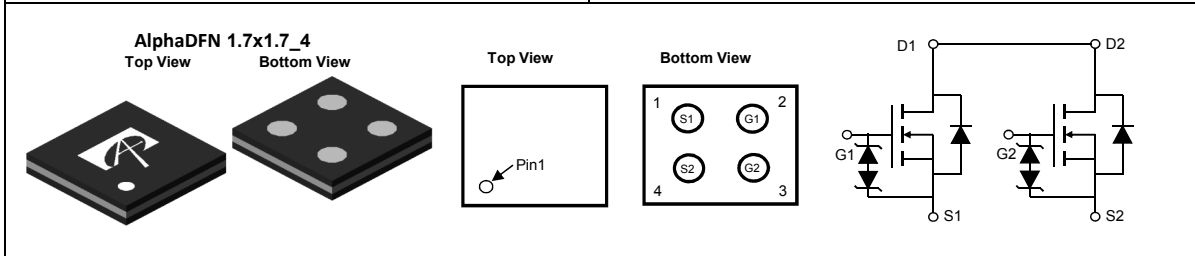


AOC2870

20V Common-Drain Dual N-Channel AlphaMOS

<p>General Description</p> <ul style="list-style-type: none"> • Trench Power AlphaMOS (αMOS LV) technology • Low $R_{SS(ON)}$ • Fully protected AlphaDFN package • With ESD protection to improve battery performance and safety • Common drain configuration for design simplicity • RoHS and Halogen-Free Compliant <p>Applications</p> <ul style="list-style-type: none"> • Battery protection switch • Mobile device battery charging and discharging 	<p>Product Summary</p> <table style="width: 100%; border-collapse: collapse;"> <tr> <td style="width: 60%;">V_{SS}</td> <td style="text-align: right;">20V</td> </tr> <tr> <td>$R_{SS(ON)}$ (at $V_{GS}=4.5V$)</td> <td style="text-align: right;">< 11.9mΩ</td> </tr> <tr> <td>$R_{SS(ON)}$ (at $V_{GS}=4.0V$)</td> <td style="text-align: right;">< 12.5mΩ</td> </tr> <tr> <td>$R_{SS(ON)}$ (at $V_{GS}=3.7V$)</td> <td style="text-align: right;">< 14mΩ</td> </tr> <tr> <td>$R_{SS(ON)}$ (at $V_{GS}=3.1V$)</td> <td style="text-align: right;">< 15.5mΩ</td> </tr> <tr> <td>$R_{SS(ON)}$ (at $V_{GS}=2.5V$)</td> <td style="text-align: right;">< 20mΩ</td> </tr> </table> <p>Typical ESD protection HBM Class 3A</p> <div style="text-align: right;">  </div>	V_{SS}	20V	$R_{SS(ON)}$ (at $V_{GS}=4.5V$)	< 11.9mΩ	$R_{SS(ON)}$ (at $V_{GS}=4.0V$)	< 12.5mΩ	$R_{SS(ON)}$ (at $V_{GS}=3.7V$)	< 14mΩ	$R_{SS(ON)}$ (at $V_{GS}=3.1V$)	< 15.5mΩ	$R_{SS(ON)}$ (at $V_{GS}=2.5V$)	< 20mΩ
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Orderable Part Number	Package Type	Form	Minimum Order Quantity
AOC2870	AlphaDFN 1.7x1.7_4	Tape & Reel	3000

Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Source-Source Voltage	V_{SS}	20	V
Gate-Source Voltage	V_{GS}	± 12	V
Source Current(DC) ^{Note1}	I_S	10	A
Source Current(Pulse) ^{Note2}	I_{SM}	50	
Power Dissipation ^{Note1}	P_D	1.4	W
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150	$^\circ\text{C}$

Thermal Characteristics

Parameter	Symbol	Typical	Units
Maximum Junction-to-Ambient	$R_{\theta JA}$	81	$^\circ\text{C/W}$
Maximum Junction-to-Ambient		90	$^\circ\text{C/W}$

Note 1. I_S rated value is based on bare silicon. Mounted on 70mmx70mm FR-4 board.

Note 2. PW <10 μs pulses, duty cycle 1% max.

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV _{SSS}	Source-Source Breakdown Voltage	I _S =250μA, V _{GS} =0V Test Circuit 6	20			V
I _{SSS}	Zero Gate Voltage Source Current	V _{SS} =20V, V _{GS} =0V Test Circuit 1 T _J =55°C			1 5	μA
I _{GSS}	Gate leakage current	V _{SS} =0V, V _{GS} =±10V Test Circuit 2			±10	μA
V _{GS(th)}	Gate Threshold Voltage	V _{SS} =V _{GS} , I _S =250μA Test Circuit 3	0.5	0.9	1.3	V
R _{SS(ON)}	Static Source to Source On-Resistance	V _{GS} =4.5V, I _S =3A Test Circuit 4 T _J =125°C	7.0	9.4	11.9	mΩ
			9.8	13.2	16.8	
		V _{GS} =4.0V, I _S =3A Test Circuit 4	7.2	9.8	12.5	mΩ
		V _{GS} =3.7V, I _S =3A Test Circuit 4	7.4	10.2	14.0	mΩ
		V _{GS} =3.1V, I _S =3A Test Circuit 4	8.0	11.1	15.5	mΩ
	V _{GS} =2.5V, I _S =3A Test Circuit 4	8.6	13.0	20	mΩ	
g _{FS}	Forward Transconductance	V _{SS} =5V, I _S =3A Test Circuit 3		30		S
V _{FSS}	Forward Source to Source Voltage	I _S =1A, V _{GS} =0V Test Circuit 5		0.68	1	V
DYNAMIC PARAMETERS						
R _g	Gate resistance	f=1MHz		2		KΩ
SWITCHING PARAMETERS						
Q _g	Total Gate Charge	V _{G1S1} =4.5V, V _{SS} =10V, I _S =3A		11.5		nC
t _{D(on)}	Turn-On DelayTime	V _{G1S1} =4.5V, V _{SS} =10V, R _L =3.3Ω, R _{GEN} =3Ω Test Circuit8		1.5		μs
t _r	Turn-On Rise Time			3.0		μs
t _{D(off)}	Turn-Off DelayTime			2.0		μs
t _f	Turn-Off Fall Time			6.0		μs

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

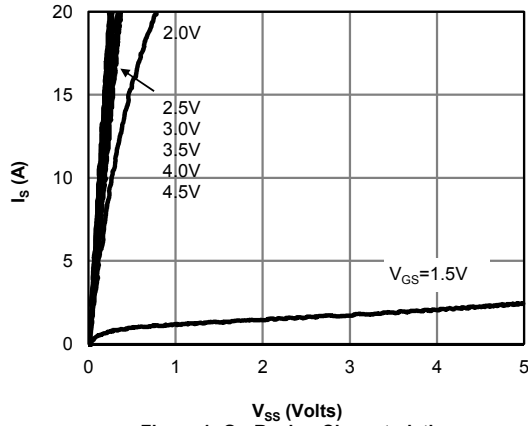


Figure 1: On-Region Characteristics

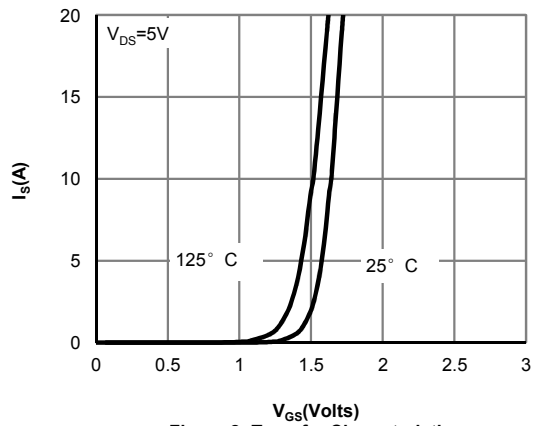


Figure 2: Transfer Characteristics

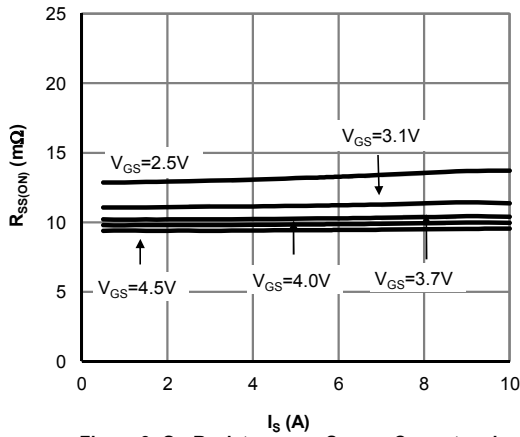


Figure 3: On-Resistance vs. Source Current and Gate Voltage

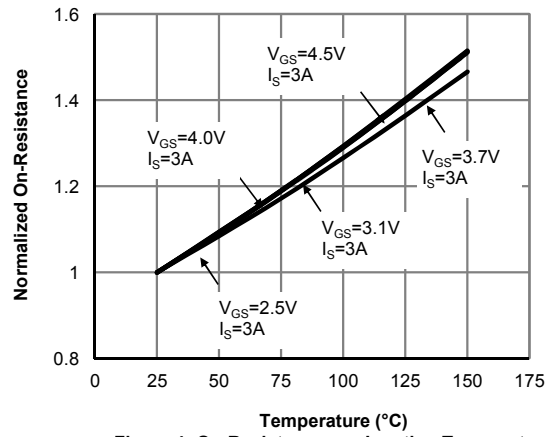


Figure 4: On-Resistance vs. Junction Temperature

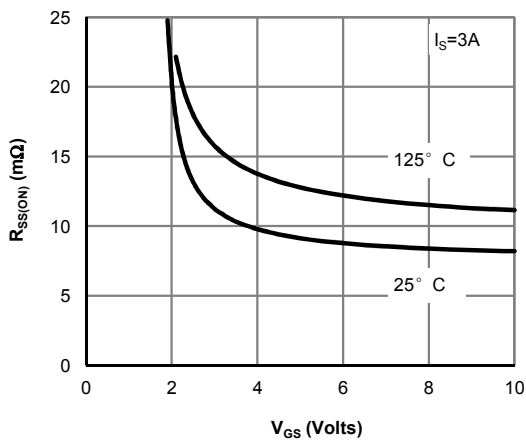


Figure 5: On-Resistance vs. Gate-Source Voltage

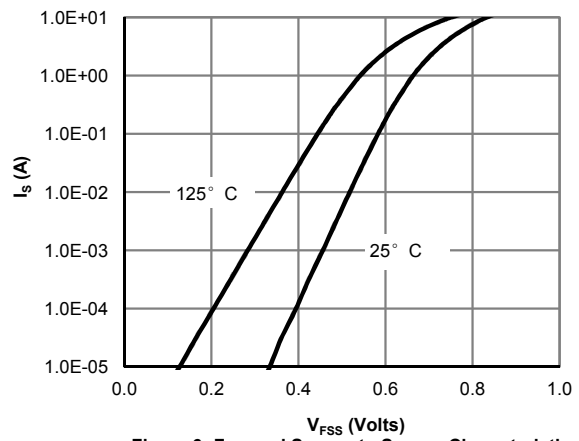


Figure 6: Forward Source to Source Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

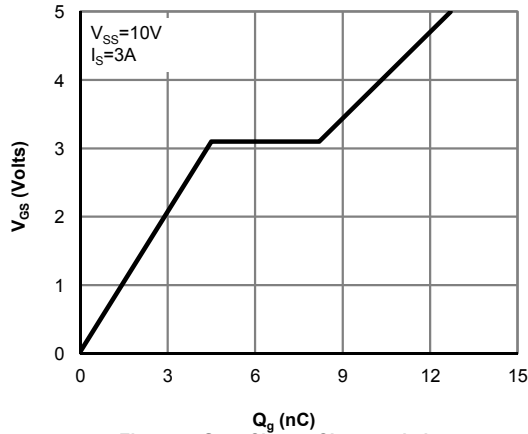


Figure 7: Gate-Charge Characteristics

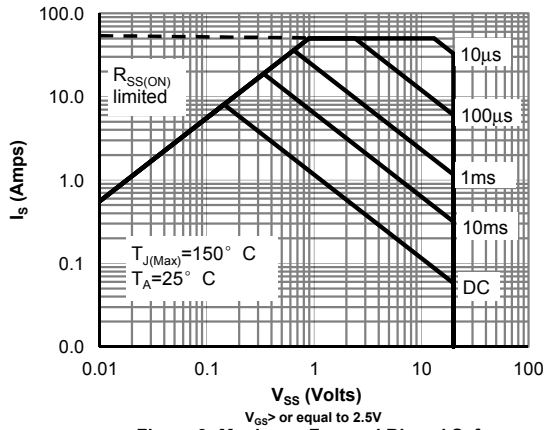


Figure 9: Maximum Forward Biased Safe Operating Area (Note1)

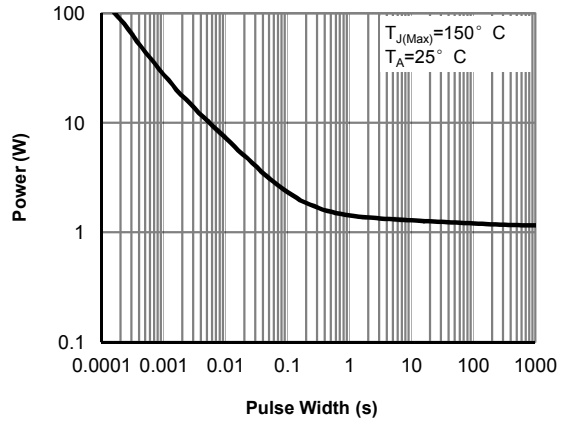


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note1)

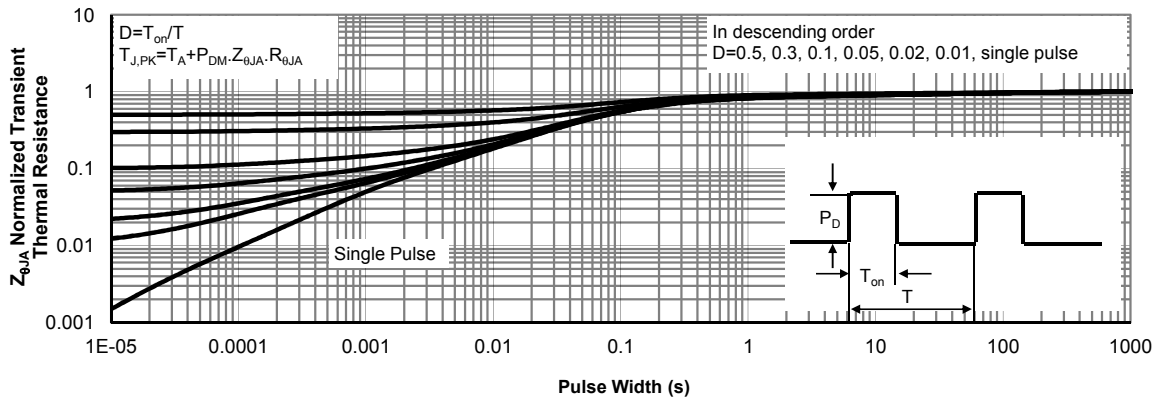


Figure 11: Normalized Maximum Transient Thermal Impedance (Note1)

